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ate: 03/22/02

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026418

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Attorney's Docket No.:

GK-HIK-2006 / 500572.20049

U.S. Application No.:

International Application No.:

PCT/JP00/06477

International Filing Date:

SEPTEMBER 21, 2000

21 SEPTEMBER 2000

Priority Date Claimed:

SEPTEMBER 24, 1999

24 SEPTEMBER 1999

Title of Invention:

A TWO-SIDE MULTIPLE LAMP TYPE ON-LINE INTERNAL

QUALITIES INSPECTION SYSTEM

Applicant(s) for (DO/EO/US):

Atsuhiro NAGAYOSHI and Hiromu MAEDA

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Commissioner of Patents Washington, D. C. 20231

INFORMATION DISCLOSURE STATEMENT

SIR:

Applicant herewith submits together with the simultaneously filed National Phase application of PCT/JP00/06477,a copy of the International Search Report (PCT/ISA/210) dated November 14, 2000 citing the following references:

	Document Number	Date	Name and/or Country	English Translation
AL	176747/1987	11/10/87	Japan	NO
AM	06-288903/	10/18/94	Japan	NO
AN	07-229840	08/29/95	Japan	NO
AO	08-201273 <	08/09/96	Japan	NO
ΑP	10-15499	01/20/98	Japan	NO

Accompanying this Information Disclosure Statement is form PTO-1449 . Copies of the documents are not readily available.

This submission is not an admission that the information disclosed in the documents is , material to the patentability of the invention disclosed and/or claimed in the above-identified application.

Respectfully submitted,

GHK:ram 03/22/02

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Tel. (212) 521-5400

Enclosures:

Search Report (PCT/ISA/210); PTO-1449;

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LIST OF PRIOR ART CITED BY APPLICANT JC13 Rec'd PCT/PTO 2 2 MAR 2002 (Filed on March 22, 2002)

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Docket No.

GK-HIK-2006 / 500572.20049

Applicant(s):

Atsuhiro NAGAYOSHI and Hiromu MAEDA

Application No.

(Int'l Appln No. PCT/JP00/06477 21SEP00) Group:

Filed:

Concurrently herewith - March 22, 2002

Examiner:

U.S. PATENT DOCUMENTS

Exam. Init		Document Number	Date	Name	Class	Sub- Class	Filing Date Appropriate
	AA	1					
	AB						
	AC						
	AD					-	
	AE						
	AF						
	AG						
	AH						
	Al						
	AJ						·
	AK						

FOREIGN PATENT DOCUMENTS

		Document				Sub-	Translation	
		Number	Date	Country	CLASS	Class	YES	NO
	AL	176747/1987	11/10/87	Japan				Х
	AM	06-288903	10/18/94	Japan				Х
•	AN	07-229840	08/29/95	Japan				Х
	AO	08-201273	08/09/96	Japan				Х
	AP	10-15499	01/20/98	Japan				Х
	AQ						•	
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	AS					1		

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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Evaminer:	D - 1 -
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.